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## **Supporting Information**

## NaBiF<sub>4</sub>: Gd/Tb nanoscintillator for high-Resolution X-ray imaging

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**Figure S1:** PXRD pattern showing the formation of  $NaBiF_4$  immediately after 1 min, 5min and 15 min of reaction.





Figure S2. The magnified XRD patterns of the (201) peak.

**Figure S3.** PXRD Rietveld refinement of (a) NaBiF<sub>4</sub>, (b) NaBiF<sub>4</sub>:24Tb and (c) NaBiF<sub>4</sub>:20Gd/20Tb nanoparticles.

**Table S1.** Refined positional parameters for hexagonal  $NaBiF_4$  nanoparticles after the final cycle of refinement.

	NaBiF <sub>4</sub>	NaBiF <sub>4</sub> :24Tb	NaBiF₄:20Gd/20Tb
Crystal Structure	Hexagonal		
Space Group	$P_{6}^{-}$		
a(Å)	6.1556(16)	6.1428(11)	6.1330(13)
c(Å)	3.7195(12)	3.69079(83)	3.6749(11)
$R_{exp}(\%)$	10.77	10.02	8.77
R <sub>p</sub> (%)	9.47	9.47	8.51
R <sub>wp</sub>	12.01	11.91	10.78
GOF(S)	1.12	1.19	1.23



Figure S4. Elemental mapping results (a-f) of NaBiF<sub>4</sub>: 20Gd/20Tb NPs (g) EDX spectrum



**Figure S5.** Integrated PL intensity profiles at various Tb<sup>3+</sup> doping contents.



Figure S6. PLE and PL spectra of NBF: Gd, Tb nanoparticles.



**Figure S7.** Afterglow spectra of the NaBiF<sub>4</sub>:20Gd/20Tb and NaBiF<sub>4</sub>:24Tb NPs recorded after cessation of X-ray irradiation immediately.



**Figure S8.** (a) Absorption spectra of PMMA-NBF film and NBF:20Gd, 20Tb(b) XEOL emission spectra of the NBF: 20Gd/20Tb NPs and the commercial CsI (Tl) single crystal, (c) Persistent luminescence decay curve of NBF: 20Gd/20Tb samples for 60 min after switching off X-ray (d) Radioluminescence stability of NBF: 20Gd/20Tb powder samples under continuous X-ray irradiation for 60 min.



Figure S9. EDX spectrum of PMMA: NBF (Gd, Tb) composite films.



**Figure S10.** (a) Transmittance spectra of the prepared films with different thickness, 3 and 6  $\mu$ m. (b) XEOL images formed of a duplex wire with the utilization of the PMMA: NBF nanoscintillator films with different thickness, 3 and 6  $\mu$ m.



**Figure S11.** (a) PL spectra and (b) transmission spectra of PMMA-NBF film with different loading percentages.



**Figure S12.** XEOL images of a duplex wire with the utilization of the PMMA: NBF composite films of loading 20%, 25%, 30%, 40% and 50%.